Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/699,155	JENNE ET AL.
Examiner	Art Unit

2827

TRONG PHAN

	0545	OUED	· · · · · · · · · · · · · · · · · · ·
	SEAR	CHED	·
Class	Subclass	Date	Examiner
365	158	5/1/2005	TP
	171	9/4/2005	TP
	173		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			_	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	5/1/2005	TP
	9/4/2005	ТР